

Search Notes 				Application/Control No. 10/670,830 Examiner Shih-wen Hsieh	Applicant(s)/Patent under Reexamination USUI ET AL.	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner		DATE	EXMR
updated	updated	8/2/2005	SWH			
251	354	8/2/2005	SWH			
INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
347	86	8/2/2005	SWH			
137	859	8/2/2005	SWH			
251	354	8/2/2005	SWH			